Supporting Information

Electrophoretic Deposition of Carbon Nitride Layers for Photoelectrochemical Applications

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Figure S1. SEM image of the C_3N_4 powder (CMB₅) used for EPD.



Figure S2. Top-view SEM image of CMB₅ deposited on FTO.



Figure S3. XRD pattern of (a) carbon paper, (b) FTO glass and (c) nickel foam with C_3N_4 deposited on top using EPD. (d) XRD pattern of the C_3N_4 powder without sonication treatment.



Figure S4. SEM images of CMB_{50} deposited on carbon paper for (a, b) 1cycle, (c, d) 3 cycles and (e, f) 5 cycles. (g) Photograph of the corresponding carbon paper pieces. The duration of each cycle was one hour.



Figure S5. SEM image of the CMB₅/CMB₅₀ electrode.



Figure S6. Transient photocurrent of the CMB_5 electrodes on carbon paper with 1, 3 and 5 EPD cycles.



Figure S7. LSV curves of (a) blank carbon paper and (b) blank FTO in dark and under illumination, scanning rate 20 mV/s in 1M KOH.